

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/034,518	CAMBLE ET AL.	
Examiner	Art Unit	
Tuan V. Thai	2186	

	SEAR	CHED	
Class	Subclass	Date	Examiner
711	100	1/18/2006	тн
711	111	1/18/2006	тн
711	112	1/18/2006	ТН
711	113	1/18/2006	ТН
711	114	1/18/2006	тн
711	154	1/18/2006	ТН
711	156	1/18/2006	ТН
711	163	1/18/2006	TH
709	213	1/18/2006	TH

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	- 1			
	0.14			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
IEEE search NPL search NORTH database EAST searches: USPGPUB DERWENTS EPO/JPO abstr IBMTDD	1/18/2006	тн		